

### FEATURES

- Flexible 8-Channel Multiplexer
- Single-Ended or Differential Inputs
- Two Gain Ranges Plus Unipolar and Bipolar Operation
- 1.25Msps Sampling Rate
- Single 5V Supply and 40mW Power Dissipation
- Scan Mode and Programmable Sequencer
- Pin Compatible 10-Bit LTC1850 and 12-Bit LTC1851
- True Differential Inputs Reject Common Mode Noise
- Internal 2.5V Reference
- Parallel Output Includes MUX Address
- Easy Interface to 3V Logic
- Nap and Sleep Shutdown Modes

### **APPLICATIONS**

- High Speed Data Acquisition
- Test and Measurement
- Imaging Systems
- Telecommunications
- Industrial Process Control
- Spectrum Analysis

# 8-Channel, 10-Bit/12-Bit, 1.25Msps Sampling ADCs

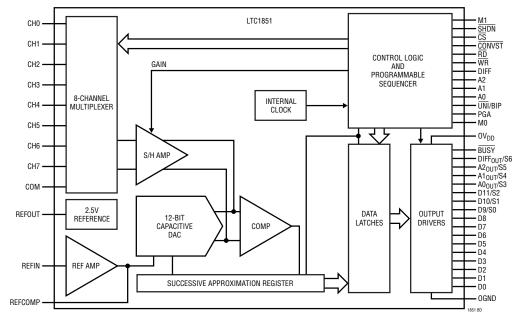
### DESCRIPTION

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The 10-bit LTC<sup>®</sup>1850 and 12-bit LTC1851 are complete 8-channel data acquisition systems. They include an extremely flexible 8-channel multiplexer, a 1.25Msps successive approximation analog-to-digital converter with sample-and-hold, an internal 2.5V reference and reference buffer amplifier, and a parallel output interface. The multiplexer can be configured for single-ended or differential inputs, two gain ranges and unipolar or bipolar operation.

The ADCs have a scan mode that will repeatedly cycle through all 8 multiplexer channels and can also be programmed with a sequence of up to 16 addresses and configurations that can be scanned in succession. The sequence memory can also be read back. The reference and buffer amplifier provide pin strappable ranges of 4.096V, 2.5V and 2.048V. The parallel output includes the 10-bit or 12-bit conversion result plus the 4-bit multiplexer address. The digital outputs are powered from a separate supply allowing for easy interface to 3V digital logic. Typical power consumption is 40mW at 1.25Msps from a single 5V supply.

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### **BLOCK DIAGRAM**



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### ABSOLUTE MAXIMUM RATINGS 0V<sub>DD</sub> = V<sub>DD</sub> (Notes 1, 2)

Supply Voltage (V <sub>DD</sub> ) 6V
Analog Input Voltage (Note 3) $\dots -0.3V$ to (V <sub>DD</sub> + 0.3V)
Digital Input Voltage (Note 4)0.3V to 10V
Digital Output Voltage $-0.3V$ to (V <sub>DD</sub> + 0.3V)
Power Dissipation

Ambient Operating Temperature Range	
LTC1850C/LTC1851C	0°C to 70°C
LTC1850I/LTC1851I	−40°C to 85°C
Storage Temperature Range	-65°C to 150°C
Lead Temperature (Soldering, 10 sec)	300°C

### PACKAGE/ORDER INFORMATION

сно Г	TOP VIEW	48 M1	ORDER PART NUMBER	СНО	TOP VIEW	48 M1	ORDER PART NUMBER
CH1 [ CH2 [ CH3 [ CH4 [ CH4 [ CH5 ] CH6 [ CH7 [ CM7 [ CM7 [ CM7 ] REFOUT [ REFOUT [ REFOUT [ REFOUT [ GND [ VD0 [ VD0 [ CM7 ] REFOUT [ Alout/S5 ] Alout/S3 [ D9/S2 ] D8/S1 ] D6 ]	1     2       3     4       5     6       7     8       9     10       11     12       13     14       15     16       17     18       19     20       21     22	47       SHDN         46       CS         45       CONVST         44       RD         43       WR         42       DIFF         41       A2         40       A1         39       A0         38       UNI/BIP         37       PGA         36       MO         35       OVDD         34       OGND         33       BUSY         32       NC         31       NC         30       D0         29       D1         28       D2         27       D3         26       D4         25       D5		CH1 CH2 CH3 CH4 CH5 CH6 CH7 COM REFOUT REF0UT REFIN REFCOMP GND VDD GND DIFF0UT/S6 A2 <sub>0UT</sub> /S5 A1 <sub>0UT</sub> /S4 A0 <sub>0UT</sub> /S3 D11/S2	$   \begin{array}{c}     1 \\     2 \\     3 \\     4 \\     5 \\     6 \\     7 \\     8 \\     9 \\     10 \\     11 \\     12 \\     13 \\     14 \\     15 \\     16 \\     17 \\     18 \\   \end{array} $	47       SHDN         46       CS         45       CONVST         44       RD         43       WR         42       DIFF         41       A2         40       A1         39       A0         38       UNI/BIP         37       PGA         36       M0         37       PGA         38       BUSY         32       D0         31       D1         30       D2         29       D3         28       D4         27       D5         26       D6         25       D7	
	$f_{\text{JMAX}} = 150^{\circ}\text{C}, \ \theta_{\text{JA}} = 110^{\circ}\text{C}$	-			$T_{JMAX} = 150^{\circ}C, \theta_{JA} = 110$		

Consult LTC Marketing for parts specified with wider operating temperature ranges.



### CONVERTER CHARACTERISTICS

<b>CONVERTER CHARP</b> temperature range, otherwise speci	<b>ACTERISTICS</b> The $\bullet$ denotes the spec fications are at T <sub>A</sub> = 25°C. (Notes 5, 6)	ificati	ons whicl	h apply	over	the full o	peratin	g
PARAMETER	CONDITIONS	MIN	LTC1850 TYP	MAX	MIN	LTC1851 TYP	MAX	ι

PARAMETER	CONDITIONS		MIN	ТҮР	MAX	MIN	ТҮР	MAX	UNITS
Resolution (No Missing Codes)		•	10			12			Bits
Integral Linearity Error	(Note 7)	•		±0.25	$\pm 0.5$		±0.35	±1	LSB
Differential Linearity Error		•		±0.25	$\pm 0.5$		±0.25	±1	LSB
Offset Error (Bipolar and Unipolar) Gain = 1 (PGA = 1) Gain = 1 (PGA = 1) Gain = 2 (PGA = 0)	(Note 8) REFCOMP $\ge 2V$ REFCOMP $\ge 2V$	•		±0.5 ±1	±2 ±4		±1 ±2	5 ±7 ±10	LSB LSB LSB
Offset Error Match					±0.5			±1	LSB
Unipolar Gain Error Gain = 1 (PGA = 1) Gain = 2 (PGA = 0)	With External 4.096V Reference Applied to REFCOMP (Note 12)				±2 ±4			±6 ±10	LSB LSB
Unipolar Gain Error Match					±0.5			±1	LSB
Bipolar Gain Error Gain = 1 (PGA = 1) Gain = 2 (PGA = 0)	With External 4.096V Reference Applied to REFCOMP (Note 12)				±2 ±4			±6 ±10	LSB LSB
Bipolar Gain Error Match					±0.5			±1	LSB
Full-Scale Error Temperature Coefficient				15			15		ppm/°C

**ANALOG INPUT** The  $\bullet$  denotes the specifications which apply over the full operating temperature range, otherwise specifications are at T<sub>A</sub> = 25°C. (Note 5)

SYMBOL	PARAMETER	CONDITIONS		MIN	ТҮР	MAX	UNITS
V <sub>IN</sub>	Analog Input Range (Note 9) Unipolar, Gain = 1 (PGA = 1) Unipolar, Gain = 2 (PGA = 0) Bipolar, Gain = 1 (PGA = 1) Bipolar, Gain = 2 (PGA = 0)	$4.75V \le V_{DD} \le 5.25V$			0 – REFCOMF 0 – REFCOMP/ ±REFCOMP/2 ±REFCOMP/2	2	V V V V
I <sub>IN</sub>	Analog Input Leakage Current	V <sub>IN</sub> > 0V < V <sub>DD</sub> , All Channels	•			±1	μA
C <sub>IN</sub>	Analog Input Capacitance	Between Conversions (Gain = 1) Between Conversions (Gain = 2) During Conversions			15 25 5		pF pF pF
t <sub>ACQ</sub>	Sample-and-Hold Acquisition Time				50	150	ns
t <sub>S(MUX)</sub>	Multiplexer Settling Time (Includes t <sub>ACQ</sub> )				50	150	ns
t <sub>AP</sub>	Sample-and-Hold Aperature Delay Time				-0.5		ns
t <sub>jitter</sub>	Sample-and-Hold Aperature Delay Time Jitter				2		ps <sub>RMS</sub>
CMRR	Analog Input Common Mode Rejection Ratio	$0V < (A_{IN}^{-} = A_{IN}^{+}) < 5V$			60		dB

### INTERNAL REFERENCE $T_A = 25^{\circ}C.$ (Notes 5, 6)

PARAMETER	CONDITIONS	MIN	ТҮР	MAX	UNITS
REFOUT Output Voltage	I <sub>OUT</sub> = 0	2.48	2.50	2.52	V
REFOUT Output Temperature Coefficient	I <sub>OUT</sub> = 0		±15		ppm/°C
REFOUT Line Regulation			0.01		LSB/V
Reference Buffer Gain	V <sub>REFCOMP</sub> /V <sub>REFIN</sub>	1.636	1.638	1.640	V/V
REFCOMP Output Voltage	External 2.5V Reference Internal 2.5V Reference	4.09 4.06	4.096 4.096	4.1 4.132	V V
REFCOMP Impedance	$REFIN = V_{DD}$		6.4		kΩ

# **DIGITAL INPUTS AND DIGITAL OUTPUTS** The $\bullet$ denotes the specifications which apply over the full operating temperature range, otherwise specifications are at T<sub>A</sub> = 25°C. (Note 5)

SYMBOL	PARAMETER	CONDITIONS		MIN	ТҮР	MAX	UNITS
V <sub>IH</sub>	High Level Input Voltage	V <sub>DD</sub> = 5.25V	•	2.4			V
VIL	Low Level Input Voltage	V <sub>DD</sub> = 4.75V	•			0.8	V
I <sub>IN</sub>	Digital Input Current	V <sub>IN</sub> = 0V to V <sub>DD</sub>	•			±5	μA
CIN	Digital Input Capacitance				2		pF
V <sub>OH</sub>	High Level Output Voltage	$V_{DD} = 4.75V, I_0 = -10\mu A$ $V_{DD} = 4.75V, I_0 = -200\mu A$	•	4.0	4.5		V V
V <sub>OL</sub>	Low Level Output Voltage	V <sub>DD</sub> = 4.75V, I <sub>0</sub> = 160μA V <sub>DD</sub> = 4.75V, I <sub>0</sub> = 1.6mA	•		0.05 0.10	0.4	V V
I <sub>OZ</sub>	Hi-Z Output Leakage D11 to D0	$V_{OUT} = 0V$ to $V_{DD}$ , CS High				±10	μA
C <sub>OZ</sub>	Hi-Z Capacitance D11 to D0	CS High (Note 9)				15	pF
ISOURCE	Output Source Current	V <sub>OUT</sub> = 0V			-20		mA
I <sub>SINK</sub>	Output Sink Current	$V_{OUT} = V_{DD}$			30		mA

**POWER REQUIREMENTS** The  $\bullet$  denotes the specifications which apply over the full operating temperature range, otherwise specifications are at T<sub>A</sub> = 25°C. (Note 5)

SYMBOL	PARAMETER	CONDITIONS		MIN	ТҮР	MAX	UNITS
V <sub>DD</sub>	Analog Positive Supply Voltage	(Note 10)	•	4.75		5.25	V
V <sub>DD</sub>	Digital Positive Supply Voltage	(Note 10)	•	4.75		5.25	V
OV <sub>DD</sub>	Output Positive Supply Voltage	(Note 10)	•	2.7		5.25	V
I <sub>DD</sub>	Positive Supply Current	$V_{DD} = V_{DD} = 0V_{DD} = 5,$ $f_{SAMPLE} = 1.25MHz$	•		8	10	mA
P <sub>DISS</sub>	Power Dissipation		•		40	50	mW
	Power Down Positive Supply Current Nap Mode Sleep Mode	$\frac{\overline{SHDN}}{SHDN} = 0V, \overline{CS} = 0V$ SHDN = 0V, CS = 5V			1 50		mA μA
	Power Down Power Dissipation Nap Mode Sleep Mode	$\frac{\overline{SHDN}}{SHDN} = 0V, \overline{CS} = 0V$ SHDN = 0V, CS = 5V			5 0.25		mW mW



## **TIMING CHARACTERISTICS** The $\bullet$ denotes the specifications which apply over the full operating temperature range, otherwise specifications are at T<sub>A</sub> = 25°C. (Note 5)

SYMBOL	PARAMETER	CONDITIONS		MIN	ТҮР	MAX	UNITS
fsample(max)	Maximum Sampling Frequency		•	1.25			MHz
	Acquisition + Conversion		•			800	ns
tCONV	Conversion Time		•			650	ns
t <sub>ACQ</sub>	Acquisition Time		•			150	ns
t <sub>1</sub>	CS to RD Setup Time	(Notes 9, 10)	•	0			ns
t <sub>2</sub>	CS to CONVST Setup Time	(Notes 9, 10)	•	10			ns
t <sub>3</sub>	CS to SHDN Setup Time	(Notes 9, 10)			200		ns
t <sub>4</sub>	SHDN to CONVST Wake-Up Time	Nap Mode (Note 10) Sleep Mode, 10µF REFCOMP Bypass Capacitor (Note 10)			200 10		ns ms
t <sub>5</sub>	CONVST Low Time	(Notes 10, 11)	•	50			ns
t <sub>6</sub>	CONVST to BUSY Delay	C <sub>L</sub> = 25pF	•		10	60	ns ns
t <sub>7</sub>	Data Ready Before BUSY		•	20 15	35		ns ns
t <sub>8</sub>	Delay Between Conversions	(Note 10)	•	50			ns
tg	Wait Time RD After BUSY		•	-5			ns
t <sub>10</sub>	Data Access Time After RD	C <sub>L</sub> = 25pF	•		20	35 45	ns ns
		C <sub>L</sub> = 100pF	•		25	45 60	ns ns
t <sub>11</sub>	BUS Relinquish Time	0°C to 70°C -40°C to 85°C	•		10	30 35 40	ns ns ns
t <sub>12</sub>	RD Low Time		•	t <sub>10</sub>			ns
t <sub>13</sub>	CONVST High Time	(Note 10)	•	50			ns
t <sub>14</sub>	Latch Setup Time	(Notes 9, 10)	•	10			ns
t <sub>15</sub>	Latch Hold Time	(Notes 9, 10)	•	10			ns
t <sub>16</sub>	WR Low Time	(Note 10)	•	50			ns
t <sub>17</sub>	WR High Time	(Note 10)	•	50			ns
t <sub>18</sub>	M1 to M0 Setup Time	(Notes 9, 10)	•	10			ns
t <sub>19</sub>	M0 to BUSY Delay	M1 High			20		ns
t <sub>20</sub>	M0 to $\overline{WR}$ (or $\overline{RD}$ ) Setup Time	(Notes 9, 10)	•	t <sub>19</sub>			ns
t <sub>21</sub>	M0 High Pulse Width	(Note 10)	•	50			ns
t <sub>22</sub>	RD High Time Between Readback Reads	(Note 10)	•	50			ns
t <sub>23</sub>	Last $\overline{WR}$ (or $\overline{RD}$ ) to M0	(Note 10)	•	10			ns
t <sub>24</sub>	M0 to RD Setup Time	(Notes 9, 10)	•	t <sub>19</sub>			ns
t <sub>25</sub>	M0 to CONVST	(Note 10)	•	t <sub>19</sub>			ns
t <sub>26</sub>	Aperture Delay				-0.5		ns
t <sub>27</sub>	Aperture Jitter				2		ps <sub>RMS</sub>

Note 1: Absolute maximum ratings are those values beyond which the life of a device may be impaired.

Note 2: All voltage values are with respect to ground with GND, OGND and GND wired together unless otherwise noted.

Note 3: When these pin voltages are taken below ground or above V<sub>DD</sub>, they will be clamped by internal diodes. This product can handle input currents of 100mA below ground or above V<sub>DD</sub> without latchup.



### ELECTRICAL CHARACTERISTICS

**Note 4:** When these pin voltages are taken below ground, they will be clamped by internal diodes. This product can handle input currents of 100mA below ground without latchup. These pins are not clamped to V<sub>DD</sub>. **Note 5:** V<sub>DD</sub> = 4.75V to 5.25V, f<sub>SAMPLE</sub> = 1.25MHz, t<sub>r</sub> = t<sub>f</sub> = 2ns unless otherwise specified.

**Note 6:** Linearity, offset and full-scale specifications apply for a singleended input on any channel with COM grounded.

**Note 7:** Integral nonlinearity is defined as the deviation of a code from a straight line passing through the actual end points of the transfer curve. The deviation is measured from the center of the quantization band.

**Note 8:** Bipolar offset is the offset voltage measured from – 0.5LSB when the output code flickers between 0111 1111 1111 and 1000 0000 0000 for LTC1851 and between 01 1111 1111 and 10 0000 0000 for LTC1850.

Note 9: Guaranteed by design, not subject to test.

Note 10: Recommended operating conditions.

**Note 11:** The falling CONVST edge starts a conversion. If CONVST returns high at a critical point during the conversion it can create small errors. For the best results, ensure that CONVST returns high either within 400ns after the start of the conversion or after BUSY rises.

**Note 12:** The analog input range is determined by the voltage on REFCOMP. The gain error specification is tested with an external 4.096V but is valid for any value of REFCOMP.

### **PIN FUNCTIONS**

**CHO to CH7 (Pins 1 to 8):** Analog Input Pins. Input pins can be used single ended relative to the analog input common pin or differentially in pairs (CH0 and CH1, CH2 and CH3, CH4 and CH5, CH6 and CH7).

**COM (Pin 9):** Analog Input Common Pin. For single-ended operation (DIFF = 0), COM is the "–" analog input. COM is disabled when DIFF is high.

**REFOUT (Pin 10):** Internal 2.5V Reference Output. Requires bypass to analog ground plane with  $1\mu$ F.

**REFIN (Pin 11):** Reference Mode Select/Reference Buffer Input. REFIN selects the Reference mode and acts as the reference buffer Input. REFIN tied to ground (Logic 0) will produce 2.048V on the REFCOMP pin. REFIN tied to the positive supply (Logic 1) disables the reference buffer to allow REFCOMP to be driven externally. For voltages between 1V and 2.6V, the reference buffer produces an output voltage on the REFCOMP pin equal to 1.6384 times the voltage on REFIN (4.096V on REFCOMP for a 2.5V input on REFIN).

**REFCOMP (Pin 12):** Reference Buffer Output. REFCOMP sets the full-scale input span. The reference buffer produces an output voltage on the REFCOMP pin equal to 1.6384 times the voltage on the REFIN pin (4.096V on REFCOMP for a 2.5V input on REFIN). REFIN tied to ground will produce 2.048V on the REFCOMP pin. REFCOMP can be driven externally if REFIN is tied to the positive supply. Requres bypass to analog ground plane with  $10\mu F$  tantalum in parallel with  $0.1\mu F$  ceramic or  $10\mu F$  ceramic.

GND (Pin 13): Ground. Tie to analog ground plane.

 $V_{DD}$  (Pin 14): 5V Supply. Bypass to analog ground plane with  $10\mu F$  tantalum in parallel with  $0.1\mu F$  ceramic or  $10\mu F$  ceramic.

 $V_{DD}$  (Pin 15): 5V Supply. Bypass to GND with 10µF tantalum in parallel with 0.1µF ceramic or 10µF ceramic.

**GND (Pin 16):** Ground for Internal Logic. Tie to analog ground plane.

**DIFF**<sub>OUT</sub>/S6 (Pin 17): Three-State Digital Data Output. Active when RD is low. Following a conversion, the singleended/differential bit of the present conversion is available on this pin concurrent with the conversion result. In Readback mode, the single-ended/differential bit of the current sequencer location (S6) is available on this pin. The output swings between  $OV_{DD}$  and OGND.

**A2<sub>0UT</sub>/S5**, **A1<sub>0UT</sub>/S4**, **A0<sub>0UT</sub>/S3** (Pins 18 to 20): Three-State Digital MUX Address Outputs. Active when  $\overline{\text{RD}}$  is low. Following a conversion, the MUX address of the present conversion is available on these pins concurrent with the conversion result. In Readback mode, the MUX address of the current sequencer location (S5-S3) is available on these pins. The outputs swing between OV<sub>DD</sub> and OGND.



### PIN FUNCTIONS

**D9/S2 (Pin 21, LTC1850):** Three-State Digital Data Output. Active when  $\overline{\text{RD}}$  is low. Following a conversion, bit 9 of the present conversion is available on this pin. In Readback mode, the unipolar/bipolar bit of the current sequencer location (S2) is available on this pin. The output swings between OV<sub>DD</sub> and OGND.

**D11/S2 (Pin 21, LTC1851):** Three-State Digital Data Output. Active when  $\overline{RD}$  is low. Following a conversion, bit 11 of the present conversion is available on this pin. In Readback mode, the unipolar/bipolar bit of the current sequencer location (S2) is available on this pin. The output swings between  $OV_{DD}$  and OGND.

**D8/S1 (Pin 22, LTC1850):** Three-State Digital Data Outputs. Active when RD is low. Following a conversion, bit 8 of the present conversion is available on this pin. In Readback mode, the gain bit of the current sequencer location (S1) is available on this pin. The output swings between OV<sub>DD</sub> and OGND.

**D10/S1 (Pin 22, LTC1851):** Three-State Digital Data Outputs. Active when RD is low. Following a conversion, bit 10 of the present conversion is available on this pin. In Readback mode, the gain bit of the current sequencer location (S1) is available on this pin. The output swings between OV<sub>DD</sub> and OGND.

**D7/S0 (Pin 23, LTC1850):** Three-State Digital Data Outputs. Active when  $\overline{RD}$  is low. Following a conversion, bit 7 of the present conversion is available on this pin. In Readback mode, the end of sequence bit of the current sequencer location (S0) is available on this pin. The output swings between  $OV_{DD}$  and OGND.

**D9/S0 (Pin 23, LTC1851):** Three-State Digital Data Outputs. Active when  $\overline{RD}$  is low. Following a conversion, bit 9 of the present conversion is available on this pin. In Readback mode, the end of sequence bit of the current sequencer location (S0) is available on this pin. The output swings between  $OV_{DD}$  and OGND.

**D6 to D0 (Pins 24 to 30, LTC1850):** Three-State Digital Data Outputs. Active when  $\overline{\text{RD}}$  is low. The outputs swing between  $OV_{DD}$  and OGND.

**D8 to D0 (Pins 24 to 32, LTC1851):** Three-State Digital Data Outputs. Active when  $\overline{\text{RD}}$  is low. The outputs swing between  $OV_{DD}$  and OGND.

NC (Pins 31, 32, LTC1850): No Connect. There is no internal connection to these pins.

**BUSY** (Pin 33): Converter Busy Output. The  $\overline{\text{BUSY}}$  output has two functions. At the start of a conversion,  $\overline{\text{BUSY}}$  will go low and remain low until the conversion is completed. The rising edge may be used to latch the output data.  $\overline{\text{BUSY}}$  will also go low while the part is in Program/Readback mode (M1 high, M0 low) and remain low until M0 is brought back high. The output swings between  $OV_{DD}$  and OGND.

**OGND (Pin 34):** Digital Data Output Ground. Tie to analog ground plane. May be tied to logic ground if desired.

 $OV_{DD}$  (Pin 35): Digital Data Output Supply. Normally tied to 5V, can be used to interface with 3V digital logic. Bypass to OGND with 10µF tantalum in parallel with 0.1µF ceramic or 10µF ceramic.

**M0 (Pin 36):** Mode Select Pin 0. Used in conjunction with M1 to select operating mode.

**PGA (Pin 37):** Gain Select Input. A high logic level selects gain = 1, a low logic level selects gain = 2.

**UNI/BIP (Pin 38):** Unipolar/Bipolar Select Input. Logic low selects a unipolar input span, a high logic level selects a bipolar input span.

A0 to A2 (Pins 39 to 41): MUX Address Input Pins.

**DIFF (Pin 42):** Single-Ended/Differential Select Input. A low logic level selects single ended, a high logic level selects differential.

### PIN FUNCTIONS

**WR** (Pin 43): Write Input. In Direct Address mode, WR low enables the MUX address and configuration input pins (Pins 37 to 42). WR can be tied low or the rising edge of WR can be used to latch the data. In Program mode, WR is used to program the sequencer. WR low enables the MUX address and configuration input pins (Pins 37 to 42). The rising edge of WR latches the data and increments the counter to the next sequencer location.

**RD** (Pin 44): Read Input. During normal operation, RD enables the output drivers when CS is low. In Readback mode (M1 high, M0 low), RD going low reads the current sequencer location, RD high advances to the next sequencer location. **CONVST (Pin 45):** Conversion Start Input. This active low signal starts a conversion on its falling edge.

**CS** (Pin 46): Chip Select Input. The chip select input must be low for the ADC to recognize the CONVST and RD inputs. If SHDN is low, a low logic level on CS selects Nap mode; a high logic level on CS selects Sleep mode.

**SHDN (Pin 47):** Power Shutdown Input. A low logic level will invoke the Shutdown mode selected by the CS pin. CS low selects Nap mode, CS high selects Sleep mode. Tie high if unused.

**M1 (Pin 48):** Mode Select Pin 1. Used in conjunction with M0 to select operating mode.





### **PIN FUNCTIONS**

PIN	NAME	DESCRIPTION	MIN	NOMINAL (V) Typ	MAX	ABSOLUTE Min	MAXIMUM (V) Max
1 to 8	CH0 to CH7	Analog Inputs	0		V <sub>DD</sub>	-0.3	V <sub>DD</sub> + 0.3
9	СОМ	Analog Input Common Pin	0		V <sub>DD</sub>	-0.3	V <sub>DD</sub> + 0.3
10	REFOUT	2.5V Reference Output		2.5		-0.3	V <sub>DD</sub> + 0.3
11	REFIN	Reference Buffer Input	0	2.5	V <sub>DD</sub>	-0.3	V <sub>DD</sub> + 0.3
12	REFCOMP	Reference Buffer Output		4.096		-0.3	V <sub>DD</sub> + 0.3
13	GND	Ground, Substrate Ground		0		-0.3	V <sub>DD</sub> + 0.3
14	V <sub>DD</sub>	Supply	4.75	5	5.25	-0.3	6
15	V <sub>DD</sub>	Supply	4.75	5	5.25	-0.3	6
16	GND	Ground		0		-0.3	V <sub>DD</sub> + 0.3
17	DIFF <sub>OUT</sub> /S6	Single-Ended/Differential Output	OGND		OV <sub>DD</sub>	-0.3	V <sub>DD</sub> + 0.3
18	A2 <sub>OUT</sub> /S5	MUX Address Output	OGND		OV <sub>DD</sub>	-0.3	V <sub>DD</sub> + 0.3
19	A1 <sub>OUT</sub> /S4	MUX Address Output	OGND		OV <sub>DD</sub>	-0.3	V <sub>DD</sub> + 0.3
20	A0 <sub>OUT</sub> /S3	MUX Address Output	OGND		OV <sub>DD</sub>	-0.3	V <sub>DD</sub> + 0.3
21	D9/S2 (LTC1850)	Data Output	OGND		OV <sub>DD</sub>	-0.3	V <sub>DD</sub> + 0.3
21	D11/S2 (LTC1851)	Data Output	OGND		OV <sub>DD</sub>	-0.3	V <sub>DD</sub> + 0.3
22	D8/S1 (LTC1850)	Data Output	OGND		OV <sub>DD</sub>	-0.3	V <sub>DD</sub> + 0.3
22	D10/S1 (LTC1851)	Data Output	OGND		OV <sub>DD</sub>	-0.3	V <sub>DD</sub> + 0.3
23	D7/S0 (LTC1850)	Data Output	OGND		OV <sub>DD</sub>	-0.3	V <sub>DD</sub> + 0.3
23	D9/S0 (LTC1851)	Data Output	OGND		OV <sub>DD</sub>	-0.3	V <sub>DD</sub> + 0.3
24 to 30	D6 to D0 (LTC1850)	Data Outputs	OGND		OV <sub>DD</sub>	-0.3	V <sub>DD</sub> + 0.3
24 to 32	D8 to D0 (LTC1851)	Data Outputs	OGND		OV <sub>DD</sub>	-0.3	V <sub>DD</sub> + 0.3
31 to 32	NC (LTC1850)						
33	BUSY	Converter Busy Output	OGND		OV <sub>DD</sub>	-0.3	V <sub>DD</sub> + 0.3
34	OV <sub>DD</sub>	Output Supply	2.7	5	5.25	-0.3	6
35	OGND	Output Ground		0		-0.3	V <sub>DD</sub> + 0.3
36	MO	Mode Select Pin 0	0		V <sub>DD</sub>	-0.3	10
37	PGA	Gain Select Input	0		V <sub>DD</sub>	-0.3	10
38	UNI/BIP	Unipolar/Bipolar Input	0		V <sub>DD</sub>	-0.3	10
39 to 41	A0 to A2	MUX Address Inputs	0		V <sub>DD</sub>	-0.3	10
42	DIFF	Single-Ended/Differential Input	0		V <sub>DD</sub>	-0.3	10
43	WR	Write Input, Active Low	0		V <sub>DD</sub>	-0.3	10
44	RD	Read Input, Active Low	0		V <sub>DD</sub>	-0.3	10
45	CONVST	Conversion Start Input, Active Low	0		V <sub>DD</sub>	-0.3	10
46	CS	Chip Select Input, Active Low	0		V <sub>DD</sub>	-0.3	10
47	SHDN	Shutdown Input, Active Low	0		V <sub>DD</sub>	-0.3	10
48	M1	Mode Select Pin 1	0		V <sub>DD</sub>	-0.3	10



The LTC1850/LTC1851 are complete and very flexible data acquisition systems. They consist of a 10-bit/12-bit, 1.25Msps capacitive successive approximation A/D converter with a wideband sample-and-hold, a configurable 8-channel analog input multiplexer, an internal reference and reference buffer amplifier, a 16-bit parallel digital output and digital control logic including a programmable sequencer.

### **CONVERSION DETAILS**

The core analog-to-digital converter in the LTC1850/ LTC1851 uses a successive approximation algorithm and an internal sample-and-hold circuit to convert an analog signal to a 10-bit/12-bit parallel output. Conversion start is controlled by the  $\overline{CS}$  and  $\overline{CONVST}$  inputs. At the start of the conversion, the successive approximation register (SAR) is reset. Once a conversion cycle is begun, it cannot be restarted. During the conversion, the internal differential 10-bit/12-bit capacitive DAC output is sequenced by the SAR from the most significant bit (MSB) to the least significant bit (LSB). The outputs of the analog input multiplexer are connected to the sample-and-hold capacitors (C<sub>SAMPLF</sub>) during the acquire phase and the comparator offset is nulled by the zeroing switches. In this acquire phase, a minimum delay of 150ns will provide enough time for the sample-and-hold capacitors to acguire the analog signal. During the convert phase, the comparator zeroing switches are open, putting the comparator into compare mode. The input switches connect C<sub>SAMPLE</sub> to ground, transferring the differential analog input charge onto the summing junction. This input charge is successively compared with the binary weighted charges supplied by the differential capacitive DAC. Bit decisions are made by the high speed comparator. At the end of the conversion, the differential DAC output balances the input charges. The SAR contents (a 10-bit/ 12-bit data word), which represents the difference of the analog input multiplexer outputs, and the 4-bit address word are loaded into the 14-bit/16-bit output latches.

#### **DYNAMIC PERFORMANCE**

#### Signal-to-Noise Ratio

The signal-to-noise plus distortion ratio [S/(N + D)] is the ratio between the RMS amplitude of the fundamental input frequency and the RMS amplitude of all other frequency components at the ADC output. The output is band limited to frequencies above DC to below half the sampling frequency. The effective number of bits (ENOBs) is a measurement of the resolution of an ADC and is directly related to the S/(N + D) by the equation:

ENOB = [S/(N + D) - 1.76]/6.02

where ENOB is the effective number of bits and S/(N + D) is expressed in dB. At the maximum sampling rate of 1.25MHz, the LTC1850/LTC1851 maintain near ideal ENOBs up to and beyond the Nyquist input frequency of 625kHz.

#### **Total Harmonic Distortion**

Total harmonic distortion is the ratio of the RMS sum of all harmonics of the input signal to the fundamental itself. The out-of-band harmonics alias into the frequency band between DC and half the sampling frequency. THD is expressed as:

$$\mathsf{THD} = 20\mathsf{Log} \frac{\sqrt{\mathsf{V2}^2 + \mathsf{V3}^2 + \mathsf{V4}^2 + \dots \mathsf{Vn}^2}}{\mathsf{V1}}$$

where V1 is the RMS amplitude of the fundamental frequency and V2 through Vn are the amplitudes of the second through nth harmonics. The LTC1850/LTC1851 have good distortion performance up to the Nyquist frequency and beyond.

#### Intermodulation Distortion

If the ADC input signal consists of more than one spectral component, the ADC transfer function nonlinearity can produce intermodulation distortion (IMD) in addition to THD. IMD is the change in one sinusoidal input caused by the presence of another sinusoidal input at a different frequency.



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If two pure sine waves of frequencies fa and fb are applied to the ADC input, nonlinearities in the ADC transfer function can create distortion products at the sum and difference frequencies of mfa  $\pm$  nfb, where m and n = 0, 1, 2, 3, etc. For example, the 2nd order IMD terms include (fa $\pm$ fb). If the two input sine waves are equal in magnitude, the value (in decibels) of the 2nd order IMD products can be expressed by the following formula:

$$IMD(fa \pm fb) = 20Log \frac{Amplitude at (fa \pm fb)}{Amplitude at fa}$$

#### Peak Harmonic or Spurious Noise

The peak harmonic or spurious noise is the largest spectral component excluding the input signal and DC. This value is expressed in decibels relative to the RMS value of a full-scale input signal.

#### Full-Power and Full-Linear Bandwidth

The full-power bandwidth is that input frequency at which the amplitude of the reconstructed fundamental is reduced by 3dB for a full-scale input signal.

The full-linear bandwidth is the input frequency at which the S/(N + D) has dropped to 68dB for the LTC1851 (11 effective bits) or 56dB for the LTC1850 (9 effective bits). The LTC1850/LTC1851 have been designed to optimize input bandwidth, allowing the ADC to undersample input signals with frequencies above the converter's Nyquist frequency. The noise floor stays very low at high frequencies; S/(N + D) becomes dominated by distortion at frequencies far beyond Nyquist.

#### ANALOG INPUT MULTIPLEXER

The analog input multiplexer is controlled using the singleended/differential pin (DIFF), three MUX address pins (A2, A1, A0), the unipolar/bipolar pin (UNI/BIP) and the gain select pin (PGA). The single-ended/differential pin (DIFF) allows the user to configure the MUX as eight singleended channels relative to the analog input common pin (COM) when DIFF is low or as four differential pairs (CH0 and CH1, CH2 and CH3, CH4 and CH5, CH6 and CH7) when DIFF is high. The channels (and polarity in the differential case) are selected using the MUX address inputs as shown

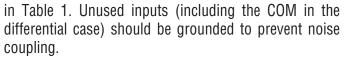


Table 1. Multiplexer Address Table

MUX		BES	S		SINGLE-ENDED CHANNEL SELECTION								
DIFF	A2	A1	AO	CHO	CH1	CH2	CH3	CH4	CH5	-	-	COM	
0	0	0	0	+								_	
0	0	0	1		+							_	
0	0	1	0			+						_	
0	0	1	1				+					_	
0	1	0	0					+				_	
0	1	0	1						+			_	
0	1	1	0							+		-	
0	1	1	1								+	-	

MUX ADDRESS			DIFFERENTIAL CHANNEL SELECTION									
DIFF	A2	A1	AO	CHO	CH1	CH2	CH3	CH4	CH5	CH6	CH7	COM
1	0	0	0	+	_							*
1	0	0	1	-	+							*
1	0	1	0			+	-					*
1	0	1	1			-	+					*
1	1	0	0					+	-			*
1	1	0	1					-	+			*
1	1	1	0							+	-	*
1	1	1	1							-	+	*

\*Not used in differential mode. Connect to GND.

In addition to selecting the MUX channel, the LTC1850/ LTC1851 also allows the user to select between two gains and unipolar or bipolar inputs for a total of four input spans. PGA high selects a gain of 1 (the input span is equal to the voltage on REFCOMP). PGA low selects a gain of 2 where the input span is equal to half of the voltage on REFCOMP. UNI/BIP low selects a unipolar input span, UNI/BIP high selects a bipolar input span. Table 2 summarizes the possible input spans.

Table 2	2. Input	Span	Table
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		INPUT SPAN			
UNI/BIP PGA			REFCOMP = 4.096V		
0	0	0 – REFCOMP/2	0-2.048V		
0	1	0 – REFCOMP	0-4.096V		
1	0	±REFCOMP/4	±1.024V		
1	1	±REFCOMP/2	±2.048V		



It should be noted that the bipolar input span of the LTC1850/LTC1851 does not allow negative inputs with respect to ground. The LTC1850/LTC1851 have a unique differential sample-and-hold circuit that allows rail-to-rail inputs. The ADC will always convert the difference of the "+" and "-" inputs independent of the common mode voltage. The common mode rejection holds up to high frequencies. The only requirement is that both inputs can not exceed the V<sub>DD</sub> power supply voltage or ground. When a bipolar input span is selected the "+" input can swing ±full scale relative to the "-" input but neither input can exceed V<sub>DD</sub> or go below ground.

Integral nonlinearity errors (INL) and differential nonlinearity errors (DNL) are independent of the common mode voltage, however, the bipolar zero error (BZE) will vary. The change in BZE is typically less than 0.1% of the common mode voltage.

Some AC applications may have their performance limited by distortion. The ADC and many other circuits exhibit higher distortion when signals approach the supply or ground. THD will degrade as the inputs approach either power supply rail. Distortion can be reduced by reducing the signal amplitude and keeping the common mode voltage at approximately midsupply.

#### **Driving the Analog Inputs**

The inputs of the LTC1850/LTC1851 are easy to drive. Each of the analog inputs can be used as a single-ended input relative to the input common pin (CHO-COM, CH1-COM, etc.) or in pairs (CHO and CH1, CH2 and CH3, CH4 and CH5, CH6 and CH7) for differential inputs. Regardless of the MUX configuration, the "+" and "-" inputs are sampled at the same instant. Any unwanted signal that is common mode to both inputs will be reduced by the common mode rejection of the sample-and-hold circuit. The inputs draw only one small current spike while charging the sample-and-hold capacitors at the end of conversion. During conversion, the analog inputs draw only a small leakage current. If the source impedance of the driving circuit is low, then the LTC1850/LTC1851 inputs can be driven directly. As source impedance increases, so will acquisition time. For minimum acquisition time with high source impedance, a buffer amplifier should be used. The only requirement is that the amplifier driving the analog input(s) must settle after the small current spike before the next conversion starts (settling time must be 150ns for full throughput rate).

#### **Choosing an Input Amplifier**

Choosing an input amplifier is easy if a few requirements are taken into consideration. First, to limit the magnitude of the voltage spike seen by the amplifier from charging the sampling capacitor, choose an amplifier that has a low output impedance (<100 $\Omega$ ) at the closed-loop bandwidth frequency. For example, if an amplifier is used in a gain of +1 and has a unity-gain bandwidth of 50MHz, then the output impedance at 50MHz should be less than 100 $\Omega$ . The second requirement is that the closed-loop bandwidth must be greater than 20MHz to ensure adequate smallsignal settling for full throughput rate. The following list is a summary of the op amps that are suitable for driving the LTC1850/LTC1851, more detailed information is available in the Linear Technology Databooks, the LinearView<sup>TM</sup> CD-ROM and on our web site at www.linear-tech.com.

**LT®1360:** 50MHz Voltage Feedback Amplifier.  $\pm 2.5V$  to  $\pm 15V$  supplies. 5mA supply current. Low distortion.

**LT1363:** 70MHz Voltage Feedback Amplifier.  $\pm 2.5V$  to  $\pm 15V$  supplies. 7.5mA supply current. Low distortion.

**LT1364/LT1365:** Dual and Quad 70MHz Voltage Feedback Amplifiers.  $\pm 2.5V$  to  $\pm 15V$  supplies. 7.5mA supply current per amplifier. Low distortion.

**LT1468/LT1469:** Single and Dual 90MHz Voltage Feedback Amplifier.  $\pm$ 5V to  $\pm$ 15V supplies. 7mA supply current per amplifier. Lowest noise and low distortion.

**LT1630/LT1631:** Dual and Quad 30MHz Rail-to-Rail Voltage Feedback Amplifiers. Single 3V to  $\pm$ 15V supplies. 3.5mA supply current per amplifier. Low noise and low distortion.

**LT1632/LT1633:** Dual and Quad 45MHz Rail-to-Rail Voltage Feedback Amplifiers. Single 3V to  $\pm$ 15V supplies. 4.3mA supply current per amplifier. Low distortion.

**LT1806/LT1807:** Single and Dual 325MHz Rail-to-Rail Voltage Feedback Amplifier. Single 3V to  $\pm$ 5V supplies. 13mA supply current. Lowest distortion.

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**LT1809/LT1810:** Single and Dual 180MHz Rail-to-Rail Voltage Feedback Amplifier. Single 3V to  $\pm$ 15V supplies. 20mA supply current. Lowest distortion.

**LT1812/LT1813:** 100MHz Voltage Feedback Amplifier. Single 5V to  $\pm$ 5V supplies. 3.6mA supply current. Low noise and low distortion.

#### Input Filtering

The noise and the distortion of the input amplifier and other circuitry must be considered since they will add to the LTC1850/LTC1851 noise and distortion. Noisy input circuitry should be filtered prior to the analog inputs to minimize noise. A simple 1-pole RC filter is sufficient for many applications. For instance, a  $100\Omega$  source resistor and a 1000pF capacitor to ground on the input will limit the input bandwidth to 1.6MHz. The capacitor also acts as a charge reservoir for the input sample-and-hold and isolates the ADC input from sampling glitch sensitive circuitry. High quality capacitors and resistors should be used since these components can add distortion. NPO and silver mica type dielectric capacitors have excellent linearity. Carbon surface mount resistors can also generate distortion from self heating and from damage that may occur during soldering. Metal film surface mount resistors are much less susceptible to both problems.

#### REFERENCE

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The LTC1850/LTC1851 include an on-chip, temperature compensated, curvature corrected, bandgap reference that is factory trimmed to 2.500V and has a very flexible 3-pin interface. REFOUT is the 2.5V bandgap output. REFIN is the input to the reference buffer and REFCOMP is the reference buffer output. The input span is determined by the voltage appearing on the REFCOMP pin as shown in Table 2. The reference buffer has a gain of 1.6384 and is factory trimmed by forcing an external 2.500V on the REFIN pin and trimming REFCOMP to 4.096V. The 3-pin interface allows for three pin-strappable Reference modes as well as two additional external Reference modes. For voltages on the REFIN pin ranging from 1V to 2.6V, the output voltage on REFCOMP will equal 1.6384 times the voltage on the REFIN pin. In this mode, the REFIN pin can be tied to REFOUT to utilize the internal 2.5V reference to get 4.096V on REFCOMP or driven with an external reference or DAC. If REFIN is tied low, the internal 2.5V reference divided by 2 (1.25V) is connected internally to the input of the reference buffer resulting in 2.048V on REFCOMP. If REFIN is tied high, the reference buffer is disabled and REFCOMP can be tied to REFOUT to achieve a 2.5V span or driven with an external reference or DAC. Table 3 summarizes the Reference modes.

#### Table 3. Reference Mode Table

MODE	REFIN	REFCOMP
REFIN Tied Low	= GND	2.048V Output
REFIN is Buffer Input	1V to 2.6V Input	1.6384V to 4.26V Output (1.6384 • REFIN)
REFIN Tied High	= V <sub>DD</sub>	Input, 6.4k $\Omega$ to Ground

#### **Full Scale and Offset**

In applications where absolute accuracy is important, offset and full-scale errors can be adjusted to zero during a calibration sequence. Offset error must be adjusted before full-scale error. Zero offset is achieved by adjusting the offset applied to the "–" input. For single-ended inputs, this offset should be applied to the COM pin. For differential inputs, the "–" input is dictated by the MUX address. For zero offset error, apply 0.5LSB (actual voltage will vary with input span selected) to the "+" input and adjust the offset at the "–" input until the output code flickers between 0000 0000 0000 and 0000 0000 1 for the LTC1851 and between 000000000 and 0000000001 for the LTC1850.

As mentioned earlier, the internal reference is factory trimmed to 2.500V. To make sure that the reference buffer gain is not compensating for trim errors in the reference, REFCOMP is trimmed to 4.096V with an accurate external 2.5V reference applied to REFIN. Likewise, to make sure that the full-scale gain trim is not compensating for errors in the reference buffer gain, the input full-scale gain is trimmed with an accurate 4.096V reference applied to REFCOMP (REFIN = 5V to disable the reference buffer). This allows the use of either a 2.5V reference applied to REFIN or a 4.096V reference applied to REFIN or a 4.096V reference applied to REFCOMP to achieve accurate results. Full-scale errors can be trimmed to zero by adjusting the appropriate reference voltage. For

unipolar inputs, an input voltage of FS - 1.5LSBs should be applied to the "+" input and the appropriate reference adjusted until the output code flickers between 1111 1111 1110 and 1111 1111 for the LTC1851 and between 11 1111 1110 and 11 1111 1111 for the LTC1850.

For bipolar inputs, an input voltage of FS - 1.5LSBs should be applied to the "+" input and the appropriate reference adjusted until the output code flickers between 0111 1111 1110 and 0111 1111 1111 for the LTC1851 and between 01 1111 1110 and 01 1111 1111 for the LTC1850.

These adjustments as well as the factory trims affect all channels. The channel-to-channel offset and gain error matching are guaranteed by design to meet the specifications in the Converter Characteristics table.

#### **OUTPUT DATA FORMAT**

The LTC1850/LTC1851 have a 14-bit/16-bit parallel output. The output word normally consists of a 10-bit/12-bit conversion result data word and a 4-bit address (three address bits  $A2_{OUT}$ ,  $A1_{OUT}$ ,  $A0_{OUT}$  and the DIFF<sub>OUT</sub> bit). The output drivers are enabled when RD is low provided the chip is selected ( $\overline{CS}$  is low). All 14/16 data output pins and BUSY are supplied by OV<sub>DD</sub> and OGND to allow easy interface to 3V or 5V digital logic.

The data format of the conversion result is automatically selected and determined by the UNI/BIP input pin. If the UNI/BIP pin is low indicating a unipolar input span (0 - REFCOMP assuming PGA = 1), the format for the data is straight binary with 1 LSB = FS/4096 (1mV for REFCOMP = 4.096V) for the LTC1851 and 1LSB = FS/1024 (4mV for REFCOMP = 4.096V) for the LTC1850.

If the UNI/BIP pin is high indicating a bipolar input span  $(\pm \text{REFCOMP}/2 \text{ for PGA} = 1)$ , the format for the data is two's complement binary with 1 LSB = [(+FS) - (-FS)]/4096 (1mV for REFCOMP = 4.096V) for the LTC1851 and 1LSB = [(+FS) - (-FS)]/1024 (4mV for REFCOMP = 4.096V) for the LTC1850.

In both cases, the code transitions occur midway between successive integer LSB values (i.e., -FS + 0.5LSB, -FS + 1.5LSB, ... -1.5LSB, -0.5LSB, 0.5LSB, 1.5LSB, ... FS - 1.5LSB, FS - 0.5LSB).

The three most significant bits of the data word (D11, D10, and D9 for the LTC1851; D9, D8 and D7 for the LTC1850) also function as output bits when reading the contents of the programmable sequencer. During readback, a 7-bit status word (S6-S0) containing the contents of the current sequencer location is available when RD is low. The individual bits of the status word are outlined in Figure 1. During readback, the D8 to D0 pins (LTC1851) or D6 to D0 pins (LTC1850) remain high impedance irrespective of the state of RD.

#### **BOARD LAYOUT AND BYPASSING**

To obtain the best performance from the LTC1850/ LTC1851, a printed circuit board with ground plane is required. The ground plane under the ADC area should be as free of breaks and holes as possible, such that a low impedance path between all ADC grounds and all ADC decoupling capacitors is provided. It is critical to prevent digital noise from being coupled to the analog inputs, reference or analog power supply lines. Layout for the printed circuit board should ensure that digital and analog signal lines are separated as much as possible. In particular, care should be taken not to run any digital track alongside an analog signal track or underneath the ADC.

An analog ground plane separate from the logic system ground should be established under and around the ADC. Pin 34 (OGND), Pin 13 (GND), Pin 16 (ADC's GND) and all other analog grounds should be connected to this single analog ground point. The bypass capacitors should also be connected to this analog ground plane. No other digital grounds should be connected to this analog ground plane. In some applications, it may be desirable to connect the  $OV_{DD}$  to the logic system supply and OGND to the logic system ground. In these cases,  $OV_{DD}$  should be bypassed to OGND instead of the analog ground plane.

Low impedance analog and digital power supply common returns are essential to the low noise operation of the ADC and the foil width for these tracks should be as wide as possible. In applications where the ADC data outputs and control signals are connected to a continuously active microprocessor bus, it is possible to get errors in the conversion results. These errors are due to feedthrough



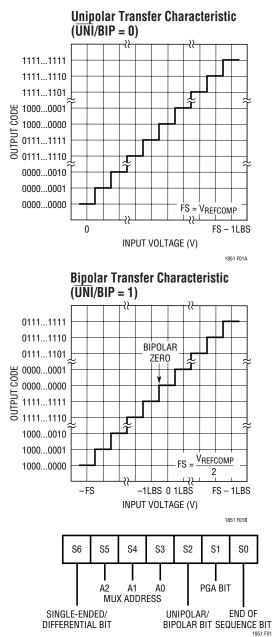


Figure 1. Readback Status Word

from the microprocessor to the successive approximation comparator. The problem can be eliminated by forcing the microprocessor into a WAIT state during conversions or by using three-state buffers to isolate the ADC bus. The traces connecting the pins and bypass capacitors must be kept short and should be made as wide as possible. The LTC1850/LTC1851 have differential inputs to minimize noise coupling. Common mode noise on the "+" and "-" inputs will be rejected by the input CMRR. The LTC1850/ LTC1851 will hold and convert the difference between whichever input is selected as the "+" input and whichever input is selected as the "-" input. Leads to the inputs should be kept as short as possible.

#### SUPPLY BYPASSING

High quality, low series resistance ceramic  $10\mu$ F bypass capacitors should be used. Surface mount ceramic capacitors such as Murata GRM235Y5V106Z016 provide excellent bypassing in a small board space. Alternatively,  $10\mu$ F tantalum capacitors in parallel with  $0.1\mu$ F ceramic capacitors can be used. Bypass capacitors must be located as close to the pins as possible. The traces connecting the pins and the bypass capacitors must be kept short and should be made as wide as possible.

#### **DIGITAL INTERFACE**

#### **Internal Clock**

The A/D converter has an internal clock that eliminates the need of synchronization between the external clock and the  $\overline{CS}$  and  $\overline{RD}$  signals found in other ADCs. The internal clock is factory trimmed to achieve a typical conversion time of 550ns, and a maximum conversion time over the full operating temperature range of 650ns. No external adjustments are required. The guaranteed maximum acquisition time is 150ns. In addition, a throughput time of 800ns and a minimum sampling rate of 1.25Msps is guaranteed.

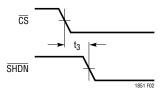


Figure 2.  $\overline{CS}$  to  $\overline{SHDN}$  Timing

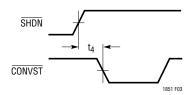


Figure 3. SHDN to  $\overline{\text{CONVST}}$  Wake-Up Timing

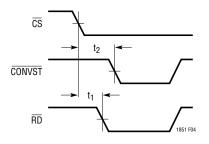


Figure 4. CS to CONVST Setup Timing

#### Power Shutdown

The LTC1850/LTC1851 provide two power shutdown modes, Nap and Sleep, to save power during inactive periods. The Nap mode reduces the power to 5mW and leaves only the digital logic and reference powered up. The wake-up time from Nap to active is 200ns. In Sleep mode, all bias currents are shut down and only leakage current remains—about  $50\mu$ A. Wake-up time from sleep mode is much slower since the reference circuit must power-up and settle to 0.005% for full 12-bit accuracy (0.02% for full 10-bit accuracy). Sleep mode wake-up time is dependent on the value of the capacitor connected to the REFCOMP (Pin 12). The wake-up time is 10ms with the recommended  $10\mu$ F capacitor.

Shutdown is controlled by Pin 47 ( $\overline{SHDN}$ ); the ADC is in shutdown when it is low. The shutdown mode is selected with Pin 46 ( $\overline{CS}$ ); low selects Nap.

### Timing and Control

Conversion start and data read operations are controlled by three digital inputs: CONVST, CS and RD. A transition from 1 to 0 applied to the CONVST pin will start a conversion after the ADC has been selected (i.e.,  $\overline{\text{CS}}$  is low). Once initiated, it cannot be restarted until the conversion is complete. Converter status is indicated by the BUSY output. BUSY is low during a conversion. If  $\overline{\text{CONVST}}$  returns high at a critical point during the conversion it can create small errors. For the best results, ensure that  $\overline{\text{CONVST}}$  returns high either within 400ns after the start of the conversion or after BUSY rises.

Figures 5 through 9 show several different modes of operation. In modes 1a and 1b (Figures 5 and 6), <u>CS and RD</u> are both tied low. The falling edge of CONVST starts the conversion. The data outputs are always enabled and data can be latched with the BUSY rising edge. Mode 1a shows operation with a narrow logic low CONVST pulse. Mode 1b shows a narrow logic high CONVST pulse.

In mode 2 (Figure 7),  $\overline{CS}$  is tied low. The falling edge of  $\overline{CONVST}$  signal again starts the conversion. Data outputs are in three-state until read by the MPU with the RD signal. Mode 2 can be used for operation with a shared MPU databus.

In slow memory and ROM modes (Figures 8 and 9),  $\overline{CS}$  is tied low and  $\overline{CONVST}$  and  $\overline{RD}$  are tied together. The MPU starts the conversion and reads the output with the  $\overline{RD}$  signal. Conversions are started by the MPU or DSP (no external sample clock).

In slow memory mode, the processor applies a logic low to  $\overline{RD}$  ( =  $\overline{CONVST}$ ), starting the conversion. BUSY goes low, forcing the processor into a Wait state. The previous conversion result appears on the data outputs. When the conversion is complete, the new conversion results appear on the data outputs; BUSY goes high releasing the processor, and the processor takes  $\overline{RD}$  ( =  $\overline{CONVST}$ ) back high and reads the new conversion data.

In ROM mode, the processor takes  $\overline{RD}$  ( =  $\overline{CONVST}$ ) low, starting a conversion and reading the previous conversion result. After the conversion is complete, the processor can read the new result and initiate another conversion.



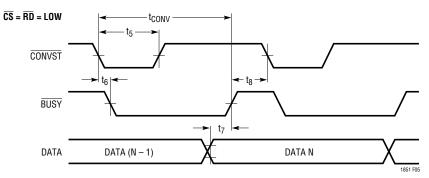


Figure 5. Mode 1a CONVST Starts a Conversion. Data Outputs Always Enabled

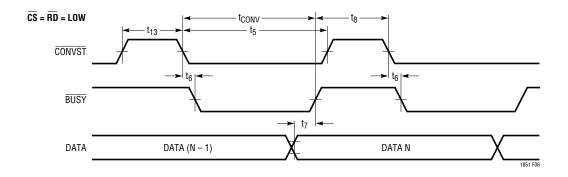


Figure 6. Mode 1b  $\overline{\text{CONVST}}$  Starts a Conversion. Data is Read by  $\overline{\text{RD}}$ 

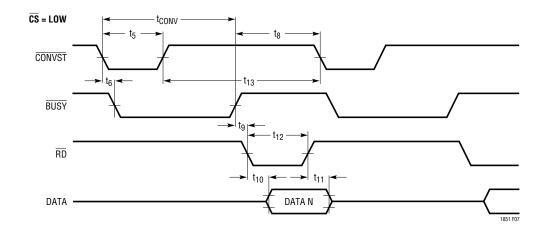


Figure 7. Mode 2  $\overline{\text{CONVST}}$  Starts a Conversion. Data is Read by  $\overline{\text{RD}}$ 

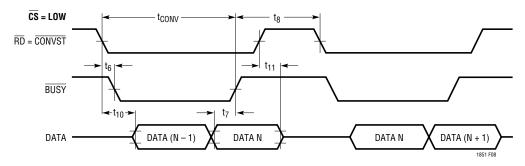


Figure 8. Slow Memory Mode Timing

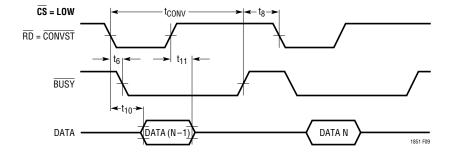


Figure 9. ROM Mode Timing

#### **MODES OF OPERATION**

#### **Direct Address Mode**

The simplest mode of operation is the Direct Address mode. This mode is selected when both the M1 and M0 pins are low. In this mode, the address input pins directly control the MUX and the configuration input pins directly control the input span. The address and configuration input pins are enabled when WR is low. WR can be tied low if the pins will be constantly driven or the rising edge of WR can be used to latch and hold the inputs for as long as WR is held high.

#### Scan Mode

Scan mode is selected when M1 is low and M0 is high. This mode allows the converter to scan through all of the input channels sequentially and repeatedly without the user having to provide an address. The address input pins (A2 to A0) are ignored but the DIFF, PGA and UNI/BIP pins are still enabled when WR is low. As in the direct address mode, WR can be held low or the rising edge of WR can be used to latch and hold the information on these pins for as long as WR is held high. The DIFF pin selects the scan pattern. If DIFF is held low, the scan pattern will consist of all eight channels in succession, single-ended relative to



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COM (CHO-COM, CH1-COM, CH2-COM, CH3-COM, CH4-COM, CH5-COM, CH6-COM, CH7-COM, repeat). At the maximum conversion rate the throughput rate for each channel would be 1.25Msps/8 or 156.25ksps. If DIFF is held high, the scan pattern will consist of four differential pairs (CH0-CH1, CH2-CH3, CH4-CH5, CH6-CH7, repeat). At the maximum conversion rate, the throughput rate for each pair would be 1.25Msps/4 or 312.5ksps. It is possible to drive the DIFF input pin while the part is in Scan mode to achieve combinations of single-ended and differential inputs. For instance, if the  $AO_{OUT}$  pin is tied to the DIFF input pin, the scan pattern will consist of four singleended inputs and two differential pairs (CHO-COM singleended, CH1-COM single-ended, CH2-CH3 differential, CH4-COM single-ended, CH5-COM single-ended, CH6-CH7 differential, repeat).

The scan counter is reset to zero whenever the M0 pin changes state so that the first conversion after M0 rises will be MUX Address 000 (CH0-COM single-ended or CH0-CH1 differential depending on the state of the DIFF pin). A conversion is initiated by the falling edge of CONVST. After each conversion, the address counter is advanced (by one if DIFF is low, by two if DIFF is high) and the MUX address for the present conversion is available on the address output pins (DIFF<sub>OUT</sub>, A2<sub>OUT</sub> to A0<sub>OUT</sub>) along with the conversion result.

#### Program/Readback Mode

The LTC1850/LTC1851 include a sequencer that can be programmed to run a sequence of up to 16 locations containing a MUX address and input configuration. The MUX address and input configuration for each location are programmed using the DIFF, A2 to A0, UNI/BIP and PGA pins and are stored in memory along with an end-of-sequence (EOS) bit that is generated automatically. The six input address and configuration bits plus the EOS bit can be read back by accessing the 7-bit readback status word (S6-S0) through the data output pins. The sequencer memory is a  $16 \times 7$  block of memory represented by the block diagram in Figure 10.

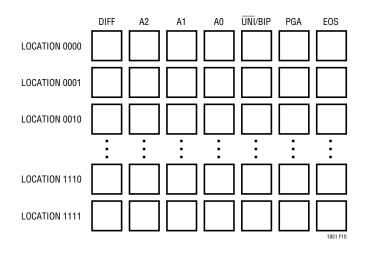


Figure 10. Sequencer Memory Block Diagram

The sequencer is accessed by taking the M1 mode pin high. With M1 high, the sequencer memory is accessed by taking the M0 mode pin low. This will cause BUSY to go low, disabling conversions during the programming and readback of the sequencer. The sequencer is reset to location 0000 whenever M1 or M0 changes state. One of these signals should be cycled prior to any read or write operation to guarantee that the sequencer will be programmed or read starting at location 0000.

The sequencer is programmed sequentially starting from location 0000. RD and WR should be held high, the appropriate signals applied to the DIFF pin, the A2 to A0 MUX address pins, the UNI/BIP pin and the PGA pin and WR taken low to write to the memory. WR going high will latch the data into memory and advance the pointer to the next sequencer location. Up to 16 locations can be programmed and the last location written before M0 is taken back high will be the last location in the sequence. After 16 writes, the pointer is reset to location 0000 and any subsequent writes will erase all of the previous contents and start a new sequence.

The sequencer memory can be read by holding  $\overline{WR}$  high and using  $\overline{RD}$ . Taking  $\overline{RD}$  low accesses the sequencer

memory and enables the data output pins. The sequencer should be reset to location 0000 before beginning a read operation. The seven output bits will be available on the DIFF<sub>OUT</sub>/S6, A2<sub>OUT</sub>/S5, A1<sub>OUT</sub>/S4, A0<sub>OUT</sub>/S3, D11/S2, D10/ S1 and D9/S0 pins (LTC1851) or DIFF<sub>OUT</sub>/S6, A2<sub>OUT</sub>/S5, A1<sub>OUT</sub>/S4, A0<sub>OUT</sub>/S3, D9/S2, D8/S1 and D7/S0 pins (LTC1850). The D8 to D0 (LTC1851) or D6 to D0 (LTC1850) data output pins will remain high impedance during readback. RD going high will return the data output pins to a high impedance state and advance the pointer to the next location. A logic 1 on the D9/S0 (or D7/S0) pin indicates the last location in the current sequence but all 16 locations can be read by continuing to clock RD. After 16 reads. the pointer is reset to location 0000. When all programming and/or reading of the sequencer memory is complete, M0 is taken high. BUSY will come back high enabling CONVST and indicating that the part is ready to start a conversion.

#### Sequence Run Mode

<u>Once</u> the sequencer is programmed, M<u>O is taken high.</u> BUSY will also come back high enabling CONVST and the

Table 5	

next falling CONVST will begin a conversion using the MUX address and input configuration stored in location 0000 of the sequencer memory. After each conversion, the sequencer pointer is advanced by one and the MUX address (the actual channel or channels being converted, not the sequencer pointer) for the present conversion is available on the address output pins along with the conversion result. When the sequencer finishes converting the last programmed location, the sequencer pointer will return to location 0000 for the next conversion. The sequencer will also reset to location 0000 anytime the M1 or M0 pin changes state.

The contents of the sequencer memory will be retained as long as power is continuously applied to the part. This allows the user to switch from Sequence Run mode to either Direct Address or Scan Mode and back without losing the programmed sequence. The part can also be disabled using  $\overline{CS}$  or shutdown in Nap or Sleep mode without losing the programmed sequence. Table 5 outlines the operational modes of the LTC1850/LTC1851. Figures 11 and 12 show the timing diagrams for writing to, reading from and running a sequence.

		1			
OPERATION MODE	M1	MO	WR	RD	COMMENTS
Direct Address	0 0	0 0	0	OE OE	Address and Configuration are Driven from External Pins Address and Configuration are Latched on Rising Edge of WR or Falling Edge of CONVST
Scan	0 0	1 1	0	OE OE	Address is Provided by Internal Scan Counter, Configuration is Driven from External Pins Configuration is Latched on Rising Edge of WR or Falling Edge of CONVST
Program	1	0	_ <b>F</b>	1	Write Sequencer Location, $\overline{WR}$ Low Enables Inputs, Rising Edge of $\overline{WR}$ Latches Data and Advances to Next Location
Readback	1	0	1	₹	Read Sequencer Location, Falling Edge of $\overline{\text{RD}}$ Enables Output, Rising Edge of $\overline{\text{RD}}$ Advances to Next Location
Sequence Run	1	1	Х	ŌĒ	Run Programmed Sequence, Falling Edge of CONVST Starts Conversion and Advances to Next Location



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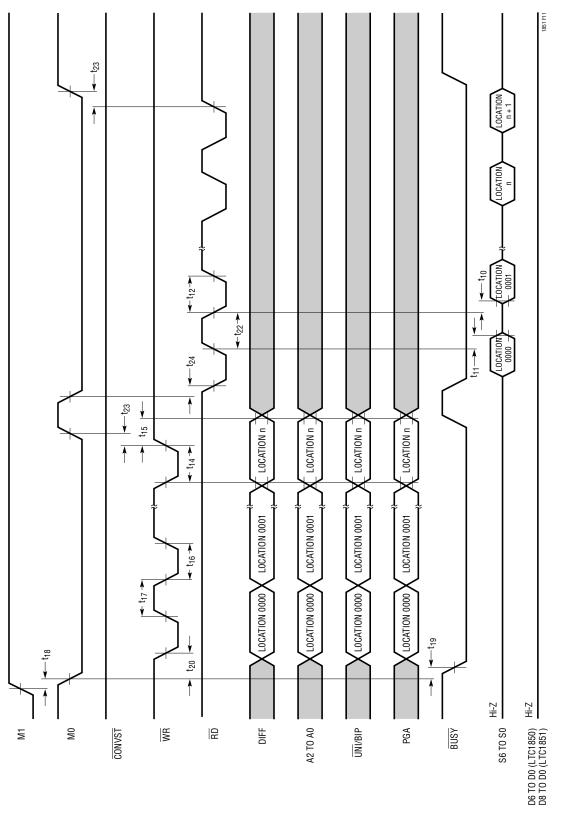


Figure 11. Sequencer I/O

LTC1850/LTC1851

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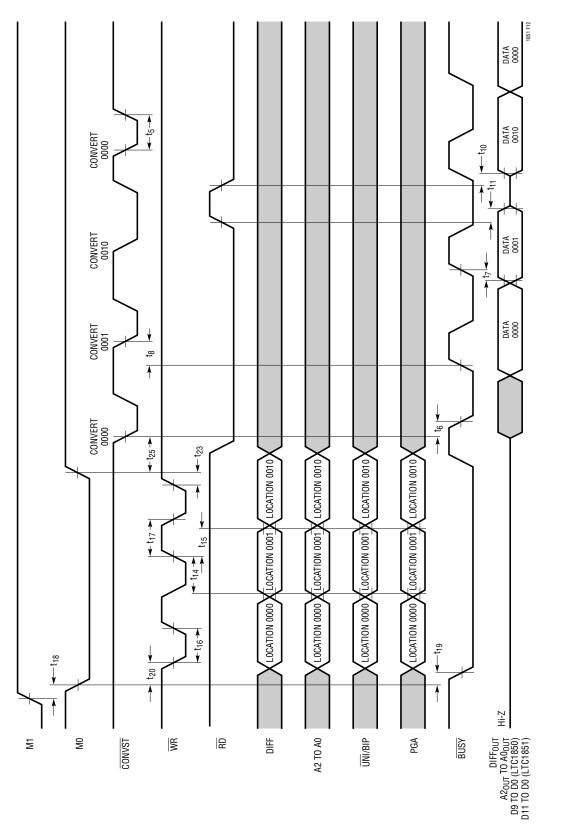
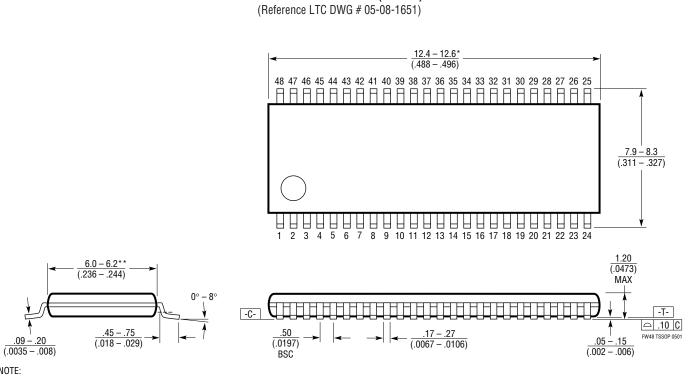


Figure 12. Programming and Running a Sequence



### PACKAGE DESCRIPTION



FW Package 48-Lead Plastic TSSOP (6.1mm)

NOTE:

1. CONTROLLING DIMENSION: MILLIMETERS

2. DIMENSIONS ARE IN MILLIMETERS (INCHES)

3. DRAWING NOT TO SCALE

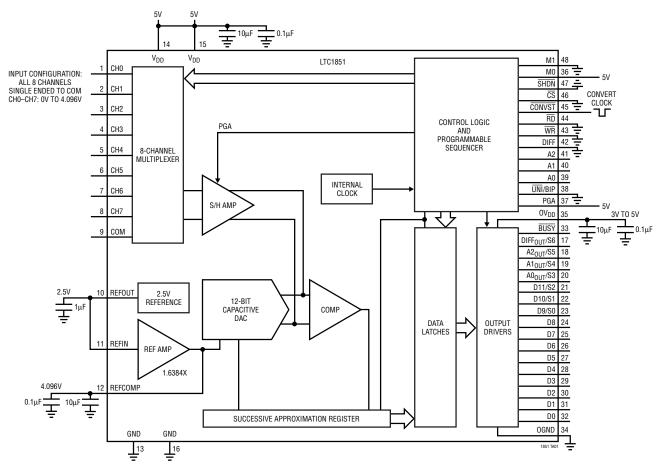
\*DIMENSIONS DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .152mm (.006") PER SIDE

\*\*DIMENSIONS DO NOT INCLUDE INTERLEAD FLASH. INTERLEAD FLASH SHALL NOT EXCEED .254mm (.010") PER SIDE



### LTC1850/LTC1851

### TYPICAL APPLICATION



### **RELATED PARTS**

PART NUMBER	DESCRIPTION	COMMENTS		
Sampling ADCs				
LTC1410	12-Bit, 1.25Msps, ±5V ADC	71.5dB SINAD at Nyquist, 150mW Dissipation		
LTC1415	12-Bit, 1.25Msps, Single 5V ADC	55mW Power Dissipation, 72dB SINAD		
LTC1418	14-Bit, 200ksps, Single 5V ADC	15mW, Serial/Parallel ±10V		
LTC1419	Low Power 14-Bit, 800ksps ADC	True 14-Bit Linearity, 81.5dB SINAD, 150mW Dissipation		
LTC1604	16-Bit, 333ksps, ±5V ADC	90dB SINAD, 220mW Power Dissipation, Pin Compatible with LTC1608		
LTC1605	16-Bit, 100ksps, Single 5V ADC	$\pm$ 10V Inputs, 55mW, Byte or Parallel I/O, Pin Compatible with LTC1606		
LTC1606	16-Bit, 250ksps, Single 5V ADC	$\pm$ 10V Inputs, 75mW, Byte or Parallel I/O, Pin Compatible with LTC1605		
LTC1608	16-Bit, 500ksps, ±5V ADC	90dB SINAD, 270mW Power Dissipation, Pin Compatible with LTC1604		
LTC1852/LTC1853	10-Bit/12-Bit, 8-Channel, 400ksps ADC	Single 3V-5V, Programmable MUX and Sequencer		
DACs				
LTC1591	14-Bit parallel, Multiplying DAC	±1LBS INL/DNL, Low Glitch, 4 Quadrant Resistors		
LTC1595	16-Bit Serial Multiplying I <sub>OUT</sub> DAC in SO-8	±1LSB Max INL/DNL, Low Glitch, DAC8043 16-Bit Upgrade		
LTC1596	16-Bit Serial Multiplying I <sub>OUT</sub> DAC	±1LSB Max INL/DNL, Low Glitch, AD7543/DAC8143 16-Bit Upgrade		
LTC1597	16-Bit Parallel, Multiplying DAC	±1LSB Max INL/DNL, Low Glitch, 4 Quadrant Resistors		
LTC1650	16-Bit Serial V <sub>OUT</sub> DAC	Low Power, Low Gritch, 4-Quadrant Multiplication		
Op Amps				
LT1468/LT1469	Single/Dual 90MHz, 22V/µs, 16-Bit Accurate Op Amp	Low Input Offset : 75µV/125µV		



